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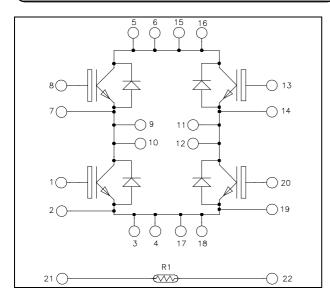




Full - Bridge <u>NPT IGBT Power Module</u>

$$V_{CES} = 1200V$$

 $I_{C} = 25A$ @ $Tc = 80$ °C

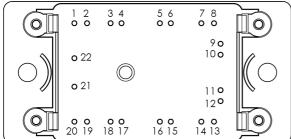


Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- Non Punch Through (NPT) Fast IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 50 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration



Pins 5/6/15/16 ; 3/4/17/18 ; 9/10 ; 11/12 must be shorted together

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

All ratings @ $T_i = 25^{\circ}C$ unless otherwise specified

Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage		1200	V
Ţ	Continuous Collector Current	$T_C = 25^{\circ}C$	40	
I_{C}	Continuous Conector Current	$T_C = 80$ °C	25	Α
I_{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_{D}	Maximum Power Dissipation	$T_C = 25^{\circ}C$	208	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125$ °C	50A@1150V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



Electrical Characteristics (per IGBT)

	Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Ī	I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V$; $V_{CE} = 1200V$				250	μΑ
	V _{CE(sat)}	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	2.5	3.2	3.7	V
			$I_C = 25A \qquad T_j = 125^{\circ}C$		4.0		v	
I	$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 1 \text{mA}$		4		6	V
	I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1MHz$			1650		
C_{oes}	Output Capacitance				250		pF
C_{res}	Reverse Transfer Capacitance				110		
Q_{g}	Total gate Charge	$V_{GE} = 15V$			160		
Q_{ge}	Gate – Emitter Charge	$V_{Bus} = 600V$			10		nC
Q_{gc}	Gate – Collector Charge	$I_C = 25A$			70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	hing (25°C)		60		
T_{r}	Rise Time	$V_{GE} = 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 25A$	$V_{\text{Bus}} = 600\text{V}$		305		ns
$T_{\rm f}$	Fall Time	$R_G = 22\Omega$		30			
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)			60		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 25A$			346		ns
$T_{\rm f}$	Fall Time	$R_G = 22\Omega$			40		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 600V$	$T_j = 125$ °C		3.5		T
E_{off}	Turn-off Switching Energy	$I_C = 25A$ $R_G = 22\Omega$	$T_j = 125$ °C		1.5		mJ
I_{sc}	Short Circuit data	$V_{GE} \le 15V ; V_{Bu}$ $t_p \le 10 \mu s ; T_j = 10$			160		A
R_{thJC}	Junction to Case Thermal Resistance					0.6	°C/W



Reverse diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage						V
I_{RM}	Maximum Reverse Leakage Current	V _R =1200V	V _R =1200V			100	μΑ
I_F	DC Forward Current		$Tc = 80^{\circ}C$		25		A
		$I_F = 25A$			2.6	3.1	
V_{F}	Diode Forward Voltage	$I_F = 50A$			3.2		V
		$I_F = 25A$	$T_j = 125$ °C		1.8		
4	Reverse Recovery Time	I_ = 25 A	$T_j = 25^{\circ}C$		320		ns
t_{rr}			$T_{j} = 125^{\circ}C$		360		113
Qrr	Reverse Recovery Charge	$di/dt = 200A/\mu s$	$T_j = 25$ °C		480		пC
			$T_{j} = 125^{\circ}C$		1800		iiC
R_{thJC}	Junction to Case Thermal Resistance	_				1.4	°C/W

Temperature sensor NTC

Symbol	Characteristic	Min	Тур	Max	Unit
R ₂₅	Resistance @ 25°C		22		kΩ
$\Delta R_{25}/R_{25}$	Resistance tolerance			5	%
$\Delta \mathrm{B/B}$	Beta tolerance			3	70
B _{25/100}	$T_{25} = 298.16 \text{ K}$		3980		K

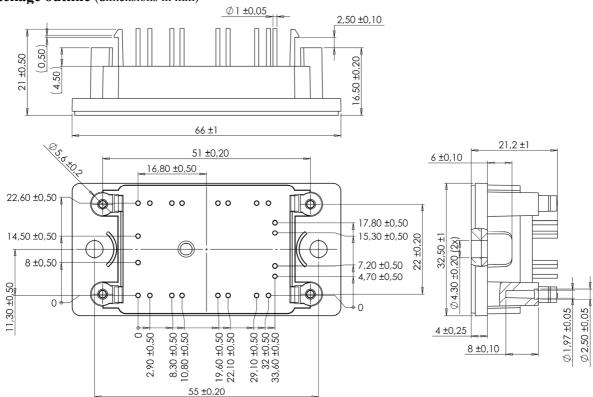
$$R_T = \frac{R_{25}}{\exp\left[B_{25/100}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R_T: Thermistor value at T

Thermal and package characteristics

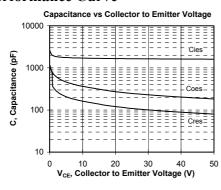
Symbol	Characteristic		Min	Тур	Max	Unit	
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz			4000			V
T_{J}	Operating junction temperature range		-40		150		
T_{STG}	Storage Temperature Range			-40		125	°C
$T_{\rm C}$	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight					75	g

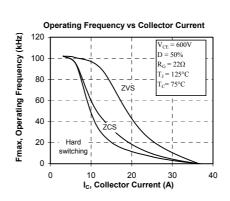


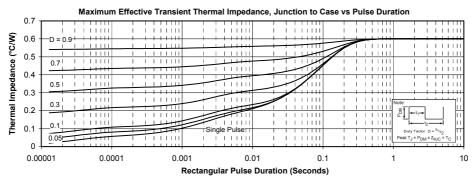
Package outline (dimensions in mm)



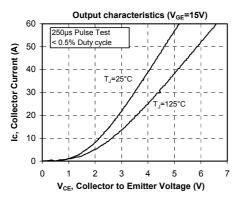
Typical Performance Curve

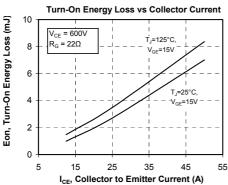


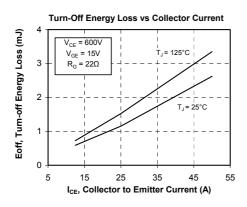


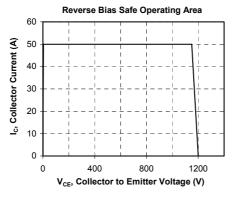


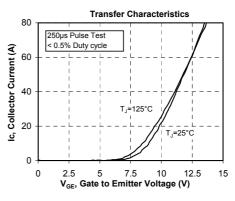


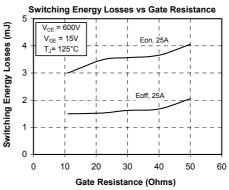


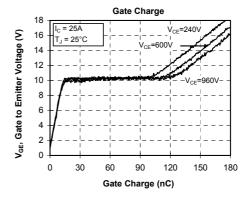






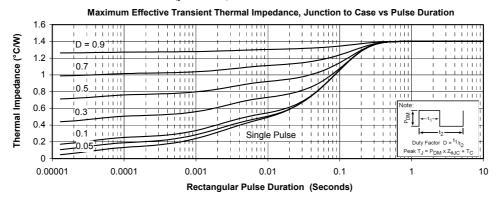


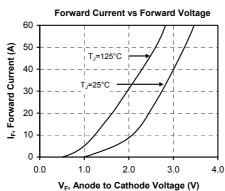






Typical diode Performance Curve (per diode)





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